

Search Notes

Application/Control No.

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Examiner

Hai H. Huynh

Applicant(s)/Patent under
Reexamination

SCHEFFEL ET AL.

Art Unit

3747

SEARCHED

Class	Subclass	Date	Examiner
123	467-470	8/29/2007	HHH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/29/2007	HHH